



## FDW2601NZ

# Dual N-Channel 2.5V Specified PowerTrench® MOSFET

### Features

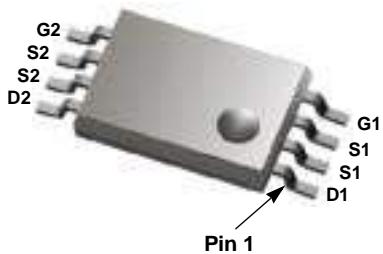
- 8.2A, 30V       $r_{DS(ON)} = 0.015\Omega$ ,  $V_{GS} = 4.5V$   
 $r_{DS(ON)} = 0.020\Omega$ ,  $V_{GS} = 2.5V$
- Extended  $V_{GS}$  range ( $\pm 12$  V) for battery applications
- HBM ESD Protection Level of 3.5kV Typical (note 3)
- High performance trench technology for extremely low  $r_{DS(ON)}$
- Low profile TSSOP-8 package

### Applications

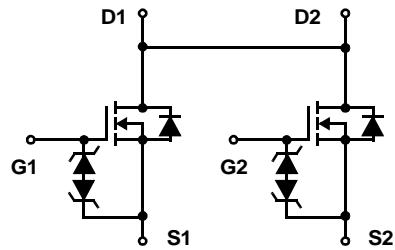
- Load switch
- Battery charge
- Battery disconnect circuits

### General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance. These devices are well suited for portable electronics applications.



TSSOP-8



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain to Source Voltage	30	V
$V_{GS}$	Gate to Source Voltage	$\pm 12$	V
$I_D$	Drain Current Continuous ( $T_C = 25^\circ\text{C}$ , $V_{GS} = 4.5\text{V}$ , $R_{\theta JA} = 77^\circ\text{C/W}$ )	8.2	A
	Continuous ( $T_C = 100^\circ\text{C}$ , $V_{GS} = 2.5\text{V}$ , $R_{\theta JA} = 77^\circ\text{C/W}$ )	4.5	A
	Pulsed	Figure 4	A
$P_D$	Power dissipation	1.6	W
	Derate above $25^\circ\text{C}$	13	$\text{mW}/^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature	-55 to 150	$^\circ\text{C}$

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 1)	77	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 2)	114	$^\circ\text{C/W}$

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2601NZ	FDW2601NZ	TSSOP-8	13"	12 mm	2500 units

### Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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#### Off Characteristics

$V_{VDSS}$	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$	30	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{V}$	-	-	1	$\mu\text{A}$
		$V_{GS} = 0\text{V}$ $T_A = 100^\circ\text{C}$	-	-	5	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 12\text{V}$	-	-	$\pm 10$	$\mu\text{A}$
		$V_{GS} = \pm 4.5\text{V}$	-	-	$\pm 250$	nA

#### On Characteristics

$V_{GS(TH)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250\mu\text{A}$	0.6	0.8	1.5	V
$r_{DS(ON)}$	Drain to Source On Resistance	$I_D = 8.2\text{A}$ , $V_{GS} = 4.5\text{V}$	-	0.011	0.015	$\Omega$
		$I_D = 7.9\text{A}$ , $V_{GS} = 4.0\text{V}$	-	0.011	0.016	$\Omega$
		$I_D = 7.3\text{A}$ , $V_{GS} = 3.1\text{V}$	-	0.012	0.019	$\Omega$
		$I_D = 7.1\text{A}$ , $V_{GS} = 2.5\text{V}$	-	0.012	0.020	$\Omega$

#### Dynamic Characteristics

$C_{ISS}$	Input Capacitance	$V_{DS} = 15\text{V}$ , $V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$	-	1840	-	pF
$C_{OSS}$	Output Capacitance		-	250	-	pF
$C_{RSS}$	Reverse Transfer Capacitance		-	160	-	pF
$R_G$	Gate Resistance	$V_{GS} = 0.5\text{V}$ , $f = 1\text{MHz}$	-	2.6	-	$\Omega$
$Q_{g(TOT)}$	Total Gate Charge at 4.5V	$V_{GS} = 0\text{V}$ to 4.5V	$V_{DD} = 15\text{V}$ $I_D = 8.2\text{A}$ $I_g = 1.0\text{mA}$	-	20	nC
$Q_{g(2.5)}$	Total Gate Charge at 2.5V	$V_{GS} = 0\text{V}$ to 2.5V		-	12	nC
$Q_{gs}$	Gate to Source Gate Charge			-	2.7	nC
$Q_{gd}$	Gate to Drain "Miller" Charge			-	5.1	nC

**Switching Characteristics** ( $V_{GS} = 4.5V$ )

$t_{ON}$	Turn-On Time	$V_{DD} = 15V, I_D = 8.2A$ $V_{GS} = 4.5V, R_{GS} = 6.8\Omega$	-	-	113	ns
$t_{d(ON)}$	Turn-On Delay Time		-	18	-	ns
$t_r$	Rise Time		-	57	-	ns
$t_{d(OFF)}$	Turn-Off Delay Time		-	69	-	ns
$t_f$	Fall Time		-	71	-	ns
$t_{OFF}$	Turn-Off Time		-	-	210	ns

**Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Voltage	$I_{SD} = 1.3A$	-	0.7	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 8.2A, dI_{SD}/dt = 100A/\mu s$	-	-	28	ns
$Q_{RR}$	Reverse Recovered Charge	$I_{SD} = 8.2A, dI_{SD}/dt = 100A/\mu s$	-	-	17	nC

**Notes:**

1.  $R_{\theta JA}$  is 77 °C/W (steady state) when mounted on a 1 inch<sup>2</sup> copper pad on FR-4.
2.  $R_{\theta JA}$  is 114 °C/W (steady state) when mounted on a miniumum copper pad on FR-4.
3. The diode connected to the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

**Typical Characteristic**  $T_A = 25^\circ\text{C}$  unless otherwise noted

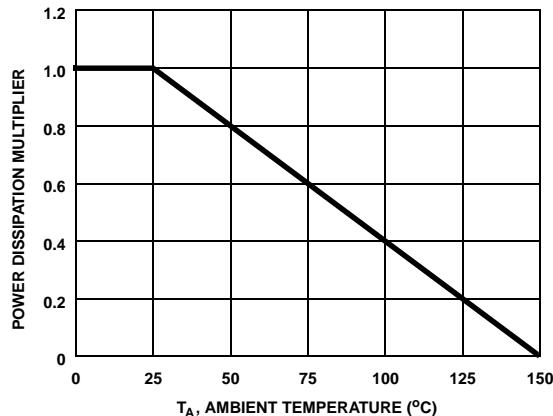


Figure 1. Normalized Power Dissipation vs Ambient Temperature

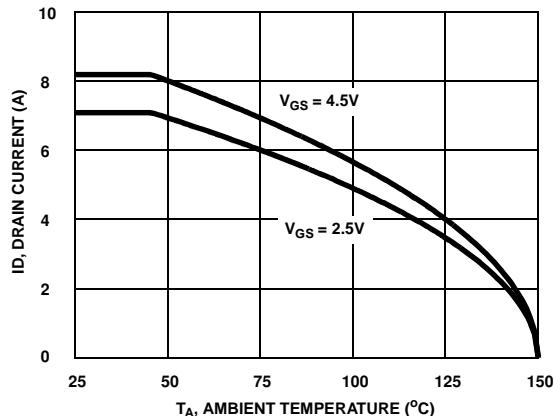


Figure 2. Maximum Continuous Drain Current vs Ambient Temperature

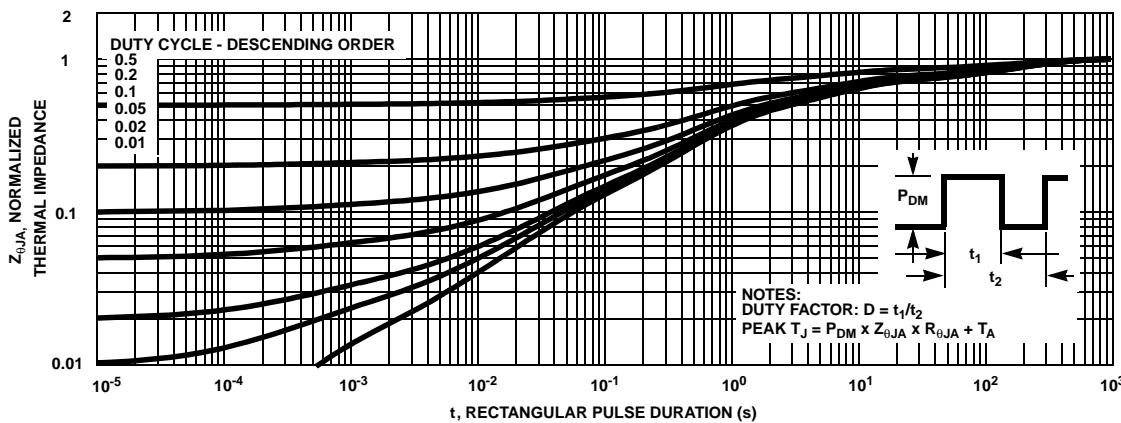


Figure 3. Normalized Maximum Transient Thermal Impedance

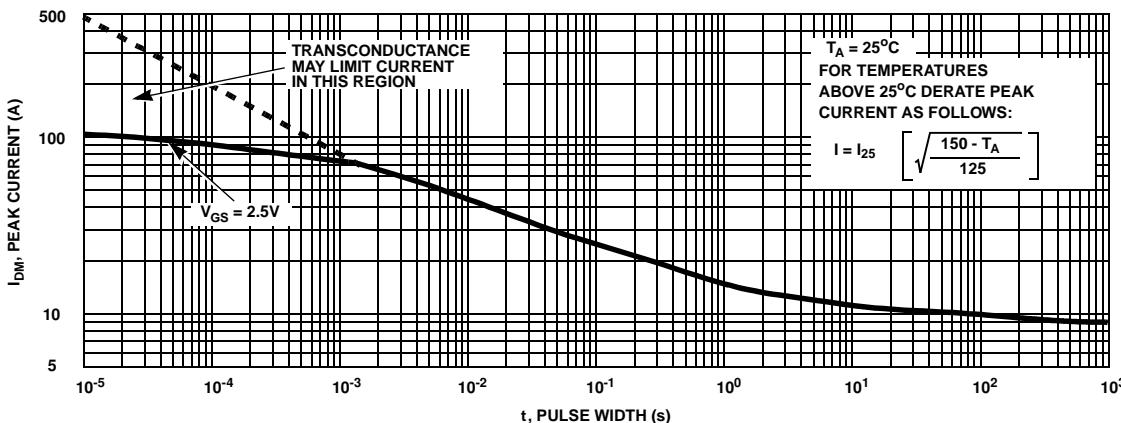
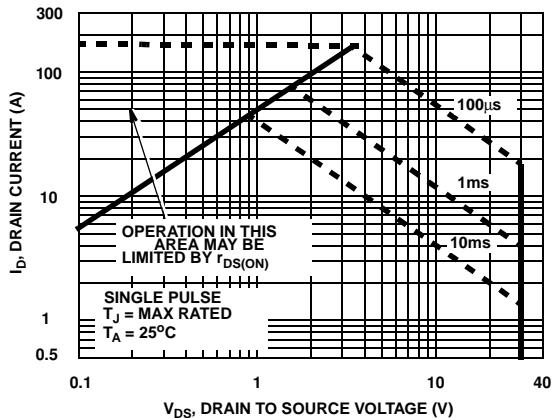
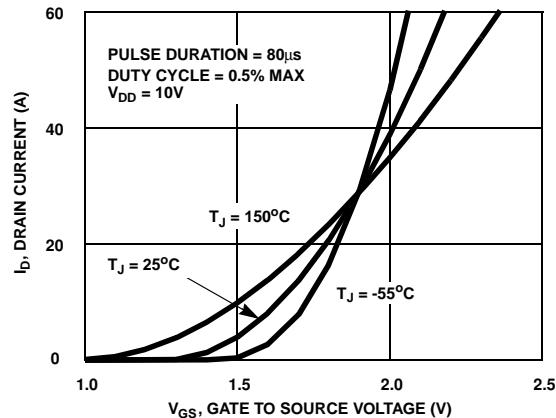


Figure 4. Peak Current Capability

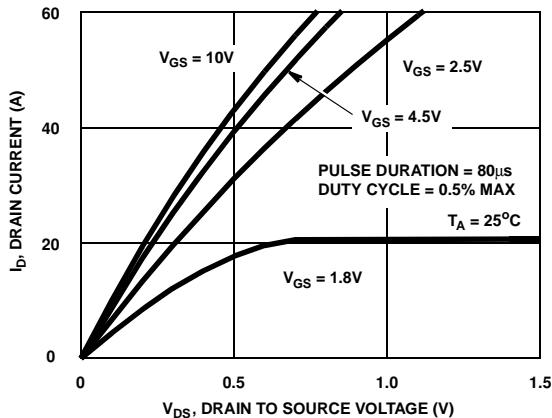
**Typical Characteristic (Continued)**  $T_A = 25^\circ\text{C}$  unless otherwise noted



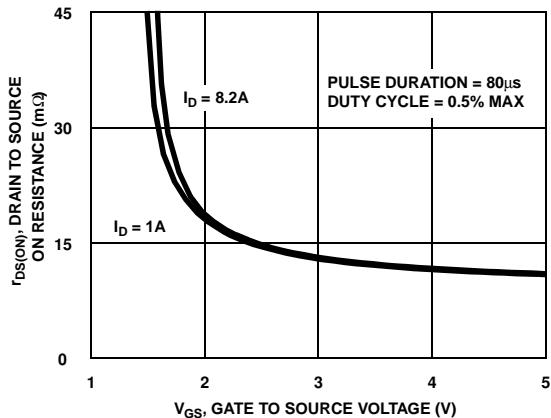
**Figure 5. Forward Bias Safe Operating Area**



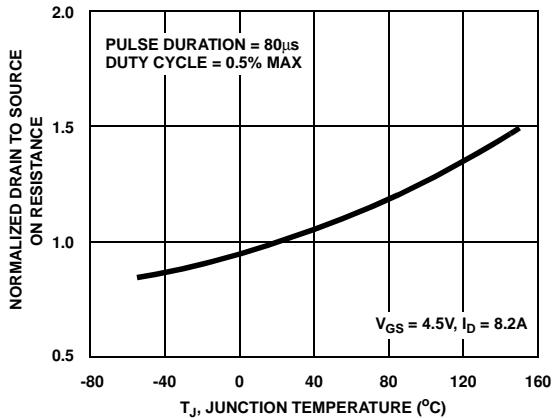
**Figure 6. Transfer Characteristics**



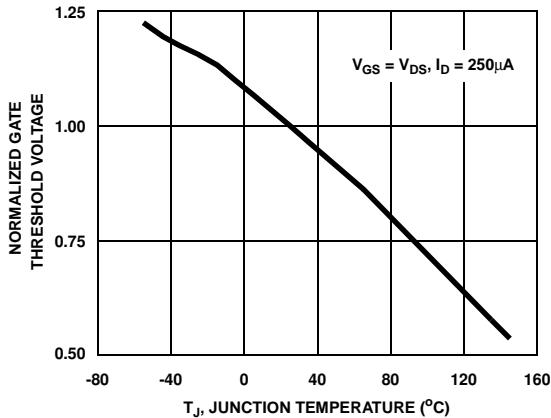
**Figure 7. Saturation Characteristics**



**Figure 8. Drain to Source On Resistance vs Gate Voltage and Drain Current**



**Figure 9. Normalized Drain to Source On Resistance vs Junction Temperature**



**Figure 10. Normalized Gate Threshold Voltage vs Junction Temperature**

**Typical Characteristic (Continued)**  $T_A = 25^\circ\text{C}$  unless otherwise noted

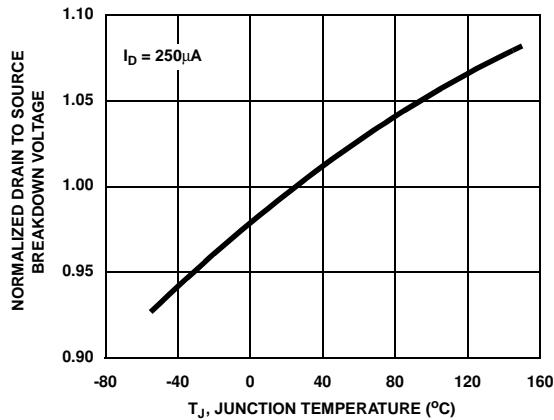


Figure 11. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

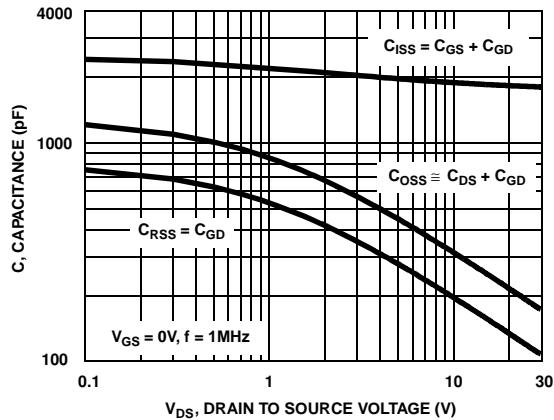


Figure 12. Capacitance vs Drain to Source Voltage

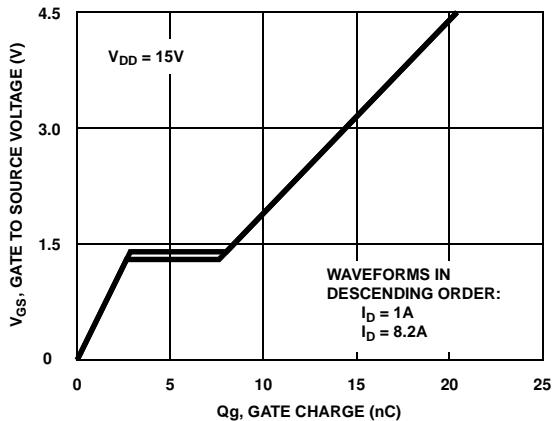


Figure 13. Gate Charge Waveforms for Constant Gate Currents

## Test Circuits and Waveforms

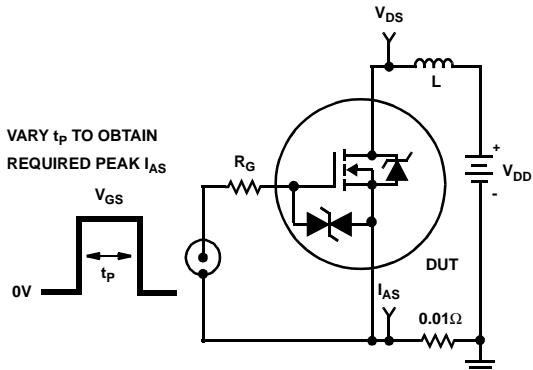


Figure 14. Unclamped Energy Test Circuit

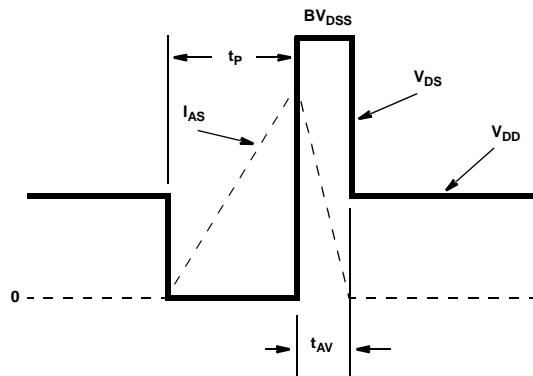


Figure 15. Unclamped Energy Waveforms

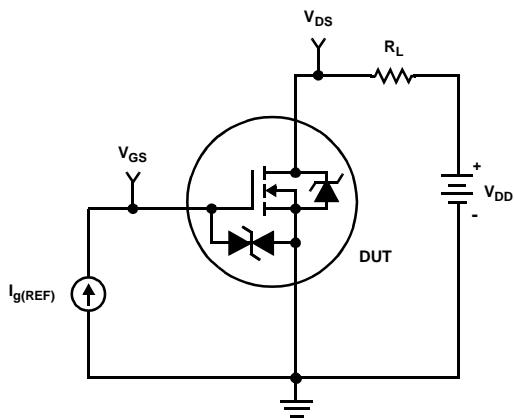


Figure 16. Gate Charge Test Circuit

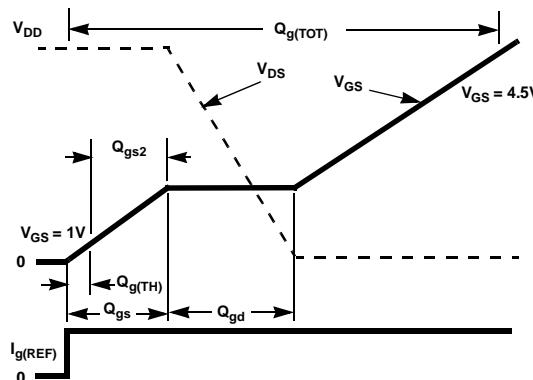


Figure 17. Gate Charge Waveforms

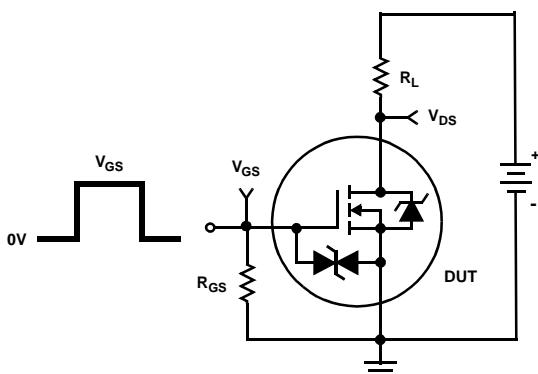


Figure 18. Switching Time Test Circuit

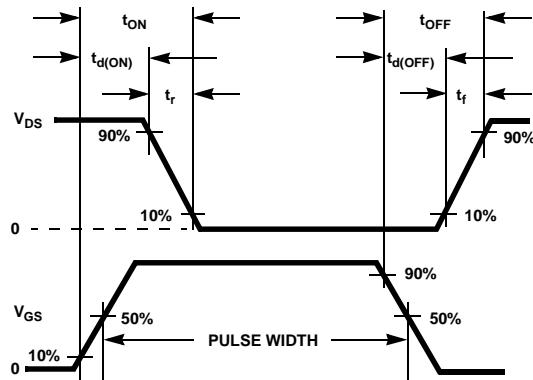


Figure 19. Switching Time Waveforms

# FDW2601NZ Dual N-Channel 2.5V Specified PowerTrench® MOSFET

## PSPICE Electrical Model

```
.SUBCKT FDW2601NZ 2 1 3 ; rev June 2004
CA 12 8 19.3e-10
CB 15 14 19.3e-10
CIN 6 8 1.7e-9
```

```
DBODY 5 7 DBODYMOD
DBREAK 7 11 DBREAKMOD
DPLCAP 10 5 DPLCAPMOD
DESD1 91 9 DESD1MOD
DESD2 91 7 DESD2MOD
EBREAK 5 11 17 18 33.3
EDS 14 8 5 8 1
EGS 13 8 6 8 1
ESG 6 10 8 6 1
EVTHRES 6 21 19.8 1
EVTEMP 6 20 18 22 1
```

```
IT 8 17 1
GATE 1 0
RGATE 9 0
RLGATE 1 9
LDRAIN 2 5 1e-9
LGATE 1 9 0.96e-9
LSOURCE 3 7 0.19e-9
```

```
RLDRAIN 2 5 10
RLGATE 1 9 9.6
RLSOURCE 3 7 1.9
```

```
MMED 16 6 8 8 MMEDMOD
MSTRO 16 6 8 8 MSTROMOD
MWEAK 16 21 8 8 MWEAKMOD
```

```
RBREAK 17 18 RBREAKMOD 1
RDRAIN 50 16 RDRAINMOD 8.8e-3
RGATE 9 20 2.75
RSCLC1 5 51 RSCLCMOD 1e-6
RSCLC2 5 50 1e3
RSOURCE 8 7 RSOURCEMOD 3e-4
RVTHRES 22 8 RVTHRESMOD 1
RVTEMP 18 19 RVTEMPPMOD 1
```

```
S1A 6 12 13 8 S1AMOD
S1B 13 12 13 8 S1BMOD
S2A 6 15 14 13 S2AMOD
S2B 13 15 14 13 S2BMOD
VBAT 22 19 DC 1
```

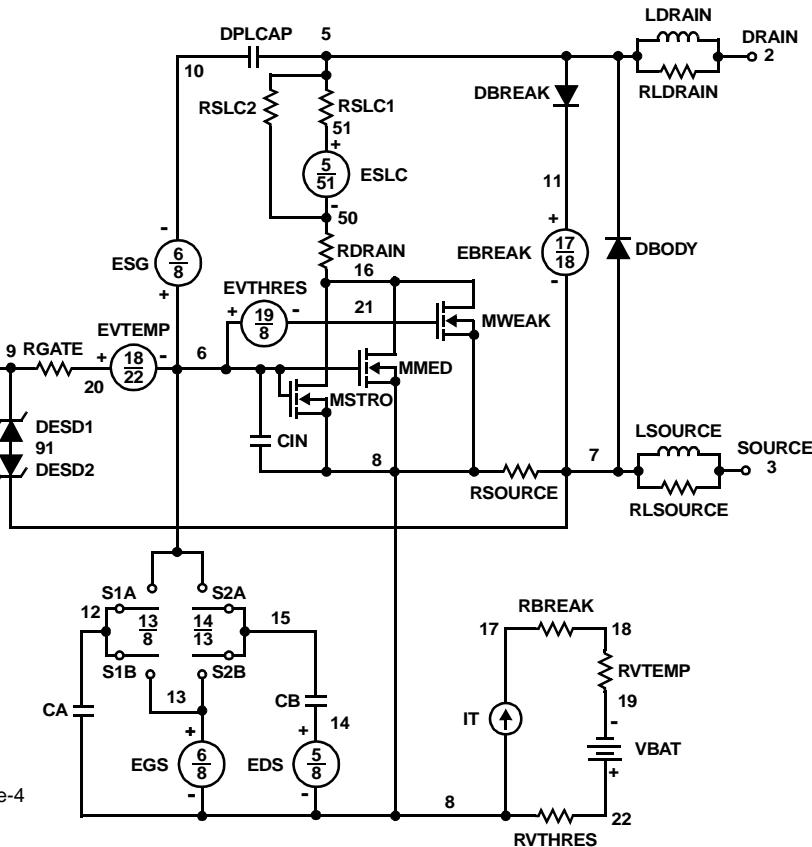
$$\text{ESLC } 51 \text{ } 50 \text{ VALUE} = ((V(5,51)/\text{ABS}(V(5,51)))*(\text{PWR}(V(5,51)/(1e-6*120),2.5)))$$

```
.MODEL DBODYMOD D (IS = 18.6e-12 N=0.93 RS = 6.6e-3 IKF=0.2 TRS1 = 1.7e-3 TRS2 = 2e-6 XTI=0.1 TIKF=0.001
CJO =5.2e-10 TT=8.7e-9 M = 0.58)
.MODEL DBREAKMOD D (RS = 1e-1 TRS1 = 9e-3 TRS2 = -2e-5)
.MODEL DPLCAPMOD D (CJO = 0.76e-9 IS = 1e-30 N = 10 M = 0.58)
.MODEL DESD1MOD D (BV=10.5 TBV1=-0.0018 N=9.4 RS=5)
.MODEL DESD2MOD D (BV=10.5 TBV1=-0.0018 N=9.4 RS=5)
.MODEL MMEDMOD NMOS (VTO = 1.0 KP = 1.7 IS=1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 2.75)
.MODEL MSTROMOD NMOS (VTO = 1.27 KP = 147 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
.MODEL MWEAKMOD NMOS (VTO = 0.83 KP = 0.05 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 27.5 RS = 0.1)
```

```
.MODEL RBREAKMOD RES (TC1 = 8.8e-4 TC2 = -13e-7)
.MODEL RDRAINMOD RES (TC1 = 1e-9 TC2 = 1e-5)
.MODEL RSCLCMOD RES (TC1 = 2e-9 TC2 = 5e-8)
.MODEL RSOURCEMOD RES (TC1 = 8.2e-2 TC2 = 1e-6)
.MODEL RVTHRESMOD RES (TC1 = -13e-4 TC2 = -2.8e-6)
.MODEL RVTEMPPMOD RES (TC1 = -1.3e-3 TC2 = 1e-6)
```

```
.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -6 VOFF= -1.5)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -1.5 VOFF= -6)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -0.5 VOFF= 0.3)
.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.3 VOFF= -0.5)
ENDS
```

Note: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



### SABER Electrical Model

```

REV June 2004
template fdw2601nz n2,n1,n3
electrical n2,n1,n3
{
var i iscl
dp..model dbodymod = (isl = 18.6e-12, nl=0.93, rs = 6.6e-3, trs1 = 1.7e-3, trs2 = 2e-6, xti=0.1, cjo = 5.2e-10, ikf=0.2, tt = 8.7e-9,
m = 0.58, tikf=0.001)
dp..model dbreakmod = (rs = 1e-1, trs1 = 9e-3, trs2 = -2.0e-5)
dp..model dplcapmod = (cjo = 0.76e-9, isl=10e-30, nl=10, m=0.58)
dp..model desd1mod = (bv=10.5, tbv1=-0.0018, nl=9.4, rs=5)
dp..model desd2mod = (bv=10.5, tbv1=-0.0018, nl=9.4, rs=5)
m..model mmedmod = (type=_n, vto = 1.0, kp=1.7, is=1e-30, tox = 1)
m..model mstrongmod = (type=_n, vto = 0.83, kp = 0.05, is = 1e-30, tox = 1, rs=0.1)
sw_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -6, voff = -1.5)
sw_vcsp..model s1bmod = (ron = 1e-5, roff = 0.1, von = -1.5, voff = -6 )
sw_vcsp..model s2amod = (ron = 1e-5, roff = 0.1, von = -0.5, voff = 0.3)
sw_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 0.3, voff = -0.5)

c.ca n12 n8 = 19.3e-10
c.cb n15 n14 = 19.3e-10
c.cin n6 n8 = 1.7e-9

dp.dbody n7 n5 = model=dbodymod
dp.dbreak n5 n11 = model=dbreakmod
dp.dplcap n10 n5 = model=dplcapmod
dp.desd1 n91 n9 = model=desd1mod
dp.desd2 n91 n7 = model=desd2mod

spe.ebreak n11 n7 n17 n18 = 33.3
spe.edb n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1
spe.evthres n6 n21 n19 n8 = 1

i.it n8 n17 = 1

I.ldrain n2 n5 = 1e-9
I.ligate n1 n9 = 0.96e-9
I.lsourc n3 n7 = 0.19e-9

res.rldrain n2 n5 = 10
res.rlgate n1 n9 = 9.6
res.rlsourc n3 n7 = 1.9

m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u

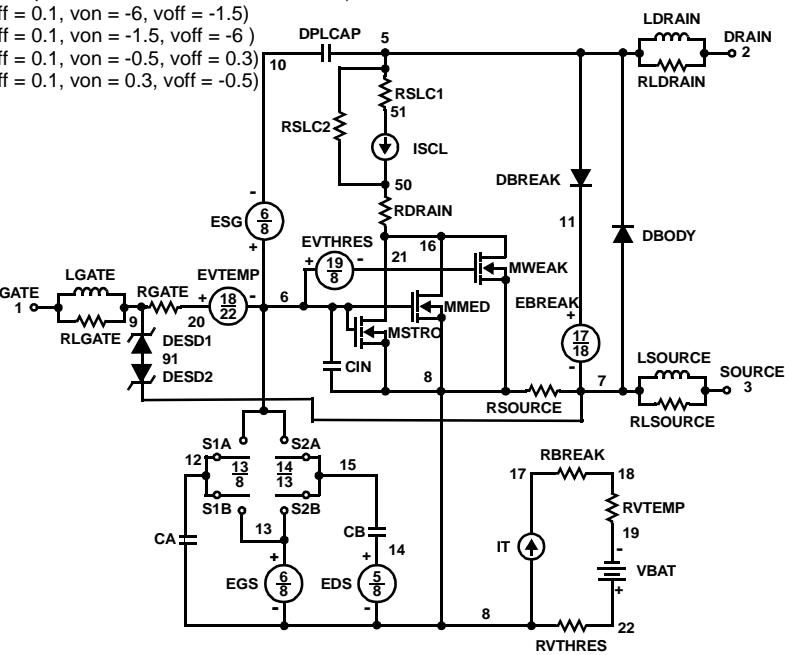
res.rbreak n17 n18 = 1, tc1 = 8.8e-4, tc2 = -13e-7
res.rdrain n50 n16 = 8.8e-3, tc1 = 1e-9, tc2 = 1e-5
res.rigate n9 n20 = 2.75
res.rslc1 n5 n51= 1e-6, tc1 = 2e-9, tc2 = 5e-8
res.rslc2 n5 n50 = 1e3
res.rsource n8 n7 = 3e-4, tc1 = 8.2e-2, tc2 = 1e-6
res.rvttemp n18 n19 = 1, tc1 = -1.3e-3, tc2 = 1e-6
res.rvthres n22 n8 = 1, tc1 = -13e-4, tc2 = -2.8e-6

sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod

v.vbat n22 n19 = dc=1

equations {
i (n51->n50) +=iscl
iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/120))** 2.5))
}
}

```



### **SPICE Thermal Model**

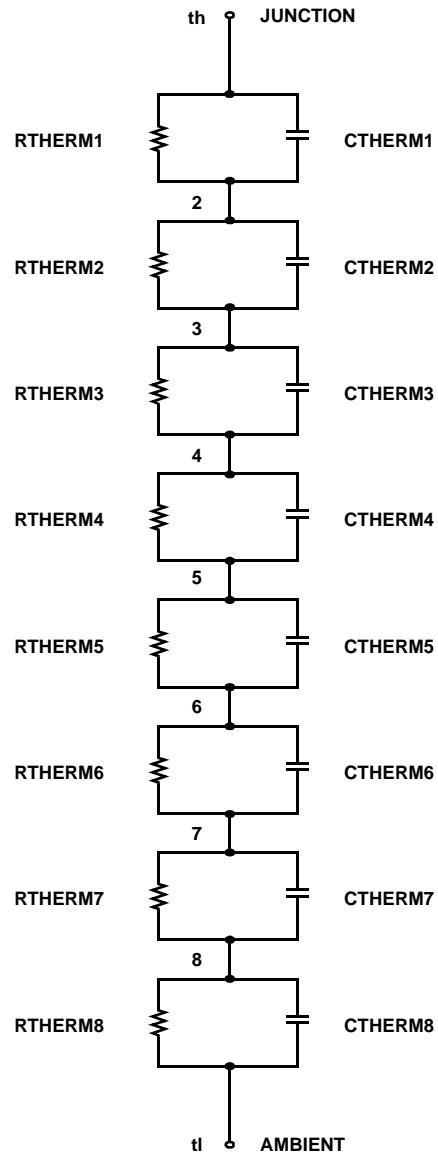
REV June 2004  
 FDW2601NZ\_JA Junction Ambient  
 Minimum copper pad area

```
CTHERM1 Junction c2 5.7e-4
CTHERM2 c2 c3 5.72e-4
CTHERM3 c3 c4 5.8e-4
CTHERM4 c4 c5 4.7e-3
CTHERM5 c5 c6 5.1e-3
CTHERM6 c6 c7 0.02
CTHERM7 c7 c8 0.2
CTHERM8 c8 Ambient 6

RTHERM1 Junction c2 0.003
RTHERM2 c2 c3 0.25
RTHERM3 c3 c4 1.0
RTHERM4 c4 c5 1.1
RTHERM5 c5 c6 7.5
RTHERM6 c6 c7 33.6
RTHERM7 c7 c8 33.7
RTHERM8 c8 Ambient 33.8
```

### **SABER Thermal Model**

SABER thermal model FDW2601NZ  
 Minimum copper pad area  
 template thermal\_model th tl  
 thermal\_c th, tl  
 {  
 ctherm.ctherm1 th c2 = 5.7e-4  
 ctherm.ctherm2 c2 c3 = 5.72e-4  
 ctherm.ctherm3 c3 c4 = 5.8e-4  
 ctherm.ctherm4 c4 c5 = 4.7e-3  
 ctherm.ctherm5 c5 c6 = 5.1e-3  
 ctherm.ctherm6 c6 c7 = 0.02  
 ctherm.ctherm7 c7 c8 = 0.2  
 ctherm.ctherm8 c8 tl = 6  
  
 rtherm.rtherm1 th c2 = 0.003  
 rtherm.rtherm2 c2 c3 = 0.25  
 rtherm.rtherm3 c3 c4 = 1.0  
 rtherm.rtherm4 c4 c5 = 1.1  
 rtherm.rtherm5 c5 c6 = 7.5  
 rtherm.rtherm6 c6 c7 = 33.6  
 rtherm.rtherm7 c7 c8 = 33.7  
 rtherm.rtherm8 c8 tl = 33.8  
 }





## TRADEMARKS

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ACE <sup>®</sup>	FPS™	PDP-SPM™	The Power Franchise <sup>®</sup>
Build it Now™	F-PFS™	Power-SPM™	the power franchise
CorePLUS™	FRFET <sup>®</sup>	PowerTrench <sup>®</sup>	TinyBoost™
CorePOWER™	Global Power Resource <sup>SM</sup>	Programmable Active Droop™	TinyBuck™
CROSSVOLT™	Green FPS™	QFET <sup>®</sup>	TinyLogic <sup>®</sup>
CTL™	Green FPS™ e-Series™	QS™	TINYOPTO™
Current Transfer Logic™	GTO™	Quiet Series™	TinyPower™
EcoSPARK <sup>®</sup>	IntelliMAX™	RapidConfigure™	TinyPWM™
EfficientMax™	ISOPLANAR™	Saving our world 1mW at a time™	TinyWire™
EZSWITCH™ *	MegaBuck™	SmartMax™	μSerDes™
	MICROCOUPLER™	SMART START™	
	MicroFET™	SPM®	UHC <sup>®</sup>
Fairchild <sup>®</sup>	MicroPak™	STEALTH™	Ultra FRFET™
Fairchild Semiconductor <sup>®</sup>	MillerDrive™	SuperFET™	UniFET™
FACT Quiet Series™	MotionMax™	SuperSOT™-3	VCX™
FACT <sup>®</sup>	Motion-SPM™	SuperSOT™-6	VisualMax™
FAST <sup>®</sup>	OPTOLOGIC <sup>®</sup>	SuperSOT™-8	
FastCore™	OPTOPLANAR <sup>®</sup>	SuperMOS™	
FlashWriter <sup>®</sup> *			

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2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

## PRODUCT STATUS DEFINITIONS

### Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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Rev. I34